



Systems for Non-Destructive Testing with Active Thermography

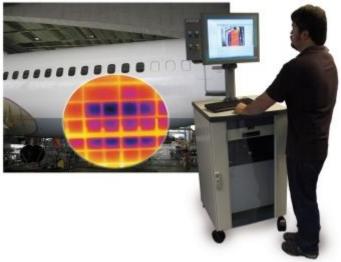
- Contactless Quality Control
- Fast, Large-Area Scans
- Modular Architecture enables Performing Lock-In, Pulse,
 Transient and Vibro Thermography Measurements, as well as TSA
- Supports a Wide Variety of Excitation Sources, e.g. Halogen Lamps,
 Flash Lamps, Laser, Ultrasound, Eddy Current, Among Others
- Presets of Inspection Parameters for the Analysis of the Most Common Materials

IRNDT

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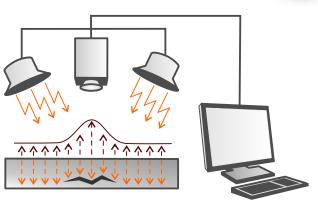
IrNDT is a modular solution for non-destructive testing that supports all known NDT techniques based on active thermography:

- → Lock-In Thermography
- → Pulse Thermography
- → Transient Thermography
- → Vibro Thermography
- → Thermal Stress Analysis (TSA)



The Measuring Principle

A heat source gives the inspected material a thermal excitation. The flow of thermal energy through the material has a direct influence on the temperature development on the object's surface. This temperature development is recorded over a certain period of time with an infrared camera and subsequently analysed by the IRNDT software. The software calculates through a mathematical analysis a result image that provides us with information about the internal structure of the material or about possible defects in it.



Main Features of IRNDT



Non-Destructive Testing of Components



Modular Software Architecture enables Easy Upgrading of System Solutions



Support of all Typical Excitation Sources for Thermographic NDT Solutions



Flexible Measuring and Evaluation Algorithms for Application-Specific Systems



Graphical Interface for Easy Set-Up of Measuring Parameters



Presets of Parameters for the Inspection of the Most Common Materials



Integrated Script-Engine for the Creation of Macros for solving Complex Inspection Tasks

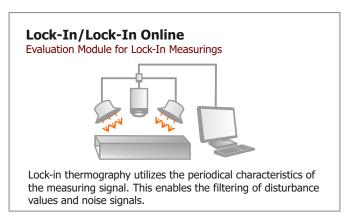


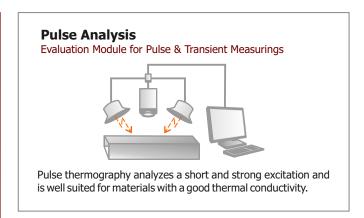
Integrated COM/DCOM Automation Interface for Control and Data Exchange

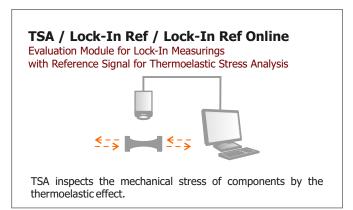
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Evaluation modules







Depending on the inspection task, the IRNDT base package is complemented with one or more evaluation modules. The different inspection methods differ not only by the type and use of the excitation source, but also by their mathematical analysis.

SolarCheck Evaluation Module for Inspection of Photovoltaic Cells SolarCheck tests elementary processes of a photovoltaic cell because they always involve heat dissipation.

By applying different measuring procedures, the system can be optimally adapted to the material analized. As a result, customers receive compact and cost effective solutions that can be upgraded anytime.

Inspection Examples

| | Lock-in Online | Lock-in | Pulse/T Short | ransient Long | TSA | Inspection Task |
|---------------------------------|-------------------|----------|------------------|------------------|----------|--|
| Halogen Lamps/ IR Emitter | 1 | 1 | - | / | - | Composite Materials (Disbondings, Delaminations, etc.) Foamed Materials (Cavities, etc.) Leather (Defects, etc.) |
| Flash Lamps | - | - | 1 | - | - | Metal (Welded Seams, Corrosion, etc.) Composite Materials (Disbondings, Delaminations, etc.) |
| Ultrasound | Y | Y | - | 1 | - | - Detection of Cracks and Delaminations |
| Laser | Y | Y | 1 | 1 | - | - Inspections, where High-Precision Energy Excitation is Required (e.g. for Small Components) |
| Eddy Current | Y | Y | - | / | - | - Metal (Cracks, etc.) |
| Mechanical Excitation | - | - | - | - | / | - Thermal Stress Analysis (TSA) |

IRNDT **Technical Specifications**

| Infrared Cameras | | | | | |
|---|---|--|--|--|--|
| Supported Cameras | Cooled and Uncooled IR Cameras of Various Manufacturers | | | | |
| Camera Interfaces | Gigabit Ethernet, Firewire (IEEE1394), IRFlashLink | | | | |
| PC | | | | | |
| PC Types | Industry PCs, Laptops (for Mobile Use) | | | | |
| Supported Operating Systems | Windows 8, 7, Vista, XP | | | | |
| Excitation Sources | | | | | |
| Light (Halogen Lamps, Infrared Emitter) | Up to 33kW | | | | |
| Flash Lamps | 6kJ - 24kJ | | | | |
| Ultrasound | - Adjustment of Frequency from 15 kHz to 25 kHz - Adjustment of Amplitude from 0 to 100% | | | | |
| Laser | High-Precision Laser with 400µm Fiber Optic Interface, Power 32W, Wave Length 808nm | | | | |
| Eddy Current | DC (Max. Power 5kW), Output Frequency Control: 8 - 30kHz | | | | |
| Mechanical Excitation | Load Frame or Similar | | | | |

IRX-Box

Modulation Box for Synchronization of all Hardware and Software Components

Enables Easy and Compact Measuring Setups

IRNDT-Software

Evaluation Modules for Lock-In, Lock-In Online, Lock-In Ref., Lock-In Ref. Online, TSA, Pulse/Transient and Photovoltaic Cell Inspection

Graphical User Interface for an Easy Creation of Customized Solutions without Programming Skills

Integrated Report Generator for Easy Set-Up of Inspection Reports, Export of Inspection Data to Matlab, Storing of Inspection Parameters in Workspaces and Storing of Result Images including its Measuring Parameters

Integrated Script-Engine for the Creation of Macros for Solving Complex Inspection Processes

| Integrated COM/DCOM Automation Interface for Control and Data Exchange | | | | |
|--|--|--|--|--|
| Measuring and Analysis Properties | | | | |
| Parameters for the Excitation Source | - Analysis Functions: Pulse, Sinus, Trapezium, Rectangle, User-Defined Function - Rectangle Width at Rectangle Modulation: 0.1 - 99.9% - Excitation Frequency: 1µHz - 50kHz | | | |
| Parameters for the IR Camera (Depending on Camera Type) | Recording Frequency, Integration Time, Temperature Range, Average Temperature, Detector Window, etc. | | | |
| Parameters for the Analysis | Several Analysis Methods, e.g. Lock-In, Pulse and Transient Thermography Special Functions for Inspection of Photovoltaic Cells and TSA (Thermal Stress Analysis) Automatic Noise Reduction Functions and Compensation of Exterior Interferences in all Analysis Modules | | | |
| Administration of Properties | Workspaces allow the Saving of all Properties | | | |